

XP161A11A1PR-VB Datasheet N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY							
V _{DS} (V)	R _{DS(on)} (Ω)	$R_{DS(on)}$ (Ω) I_{D} (A) ^a Q_{g}					
20	0.022 at V _{GS} = 4.5 V	6.8	10 nC				
30	0.030 at V _{GS} = 2.5 V	6.0	TUTIC				

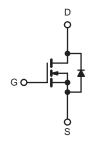
FEATURES

- Halogen-free
- Trench Power MOSFET

APPLICATIONS

Load Switches for Portable Devices





N-Channel MOSFET

ABSOLUTE MAXIMUM RATIN	IGS T _A = 25 °C,	unless otherw	rise noted		
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	30	V	
Gate-Source Voltage	V _{GS}	± 20	V		
	T _C = 25 °C		6.8 ^a		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C		6 ^a		
	T _A = 25 °C		6.8 ^{a, b, c}		
	T _A = 70 °C		6 ^{a, b, c}	A	
Pulsed Drain Current	I _{DM}	30			
Continuous Source-Drain Diode Current $T_{C} =$			5.2		
Continuous Source-Drain Diode Current	T _A = 25 °C	Is –	2.1 ^{b, c}		
	T _C = 25 °C		6.3		
Maximum Bawar Dissipation	T _C = 70 °C	P _D	4	W	
Maximum Power Dissipation	T _A = 25 °C	'D	2.5 ^{b, c}	V V	
	T _A = 70 °C		1.6 ^{b, c}		
Operating Junction and Storage Temperatur	T _J , T _{stg}	- 55 to 150	°C		
Soldering Recommendations (Peak Temperation	ature) ^{e, f}		260	U U	

THERMAL RESISTANCE BATINGS

Parameter	Symbol Typical		Maximum	Unit					
Maximum Junction-to-Ambient ^{a, c, d}	t ≤ 5 s	R _{thJA}	40	50	°C/W				
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	15	20	0/11				

Notes:

a. Package limited, T_C = 25 °C.
b. Surface Mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. Maximum under Steady State conditions is 95 °C/W.

e. See Reliability Manual for profile. The ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

f. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

D G S D

SPECIFICATIONS $T_J = 25 \text{ °C}, T_J $	· · · · · · · · · · · · · · · · · · ·			.		11
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static	N			1		
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	30			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		25		mV/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			- 4.0		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	0.6		1.5	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1	
	.032	V_{DS} = 30 V, V_{GS} = 0 V, T_{J} = 55 °C			10	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \geq 5$ V, V_{GS} = 4.5 V	30			А
	P	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 6.3 \text{ A}$		0.022		0
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 2.5 \text{ V}, I_D = 4.5 \text{ A}$		0.030		Ω
Forward Transconductance ^a	9 _{fs}	V _{DS} = 10 V, I _D = 6.3 A		45		S
Dynamic ^b					•	1
Input Capacitance	C _{iss}			1200		
Output Capacitance	C _{oss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		220		pF
Reverse Transfer Capacitance	C _{rss}			100		
T () Q () Q	0	$V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 6.3 \text{ A}$		22	33	nC
Total Gate Charge	Qg			10	15	
Gate-Source Charge	Q _{gs}	V_{DS} = 10 V, V_{GS} = 4.5 V, I_{D} = 6.3 A		2.5		
Gate-Drain Charge	Q _{gd}			1.7		
Gate Resistance	Rg	f = 1 MHz		2.4		Ω
Turn-on Delay Time	t _{d(on)}			15	25	
Rise Time	t _r	$V_{DD} = 10 \text{ V}, \text{ R}_{1} = 1.5 \Omega$		10	15	- ns
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 6.7 \text{ Å}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		35	55	
Fall Time	t _f			12	20	
Turn-on Delay Time	t _{d(on)}			10	15	
Rise Time	t _r	$V_{DD} = 10 \text{ V}, \text{ R}_1 = 1.5 \Omega$		12	20	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 6.7 \text{ A}, V_{GEN} = 10 \text{ V}, \text{R}_q = 1 \Omega$		25	40	
Fall Time	t _f			10	15	
Drain-Source Body Diode Characteristic	s		<u> </u>	1		I
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			5.2	•
Pulse Diode Forward Current	I _{SM}				30	A
Body Diode Voltage	V _{SD}	I _S = 6.7 A, V _{GS} = 0 V		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			20	40	ns
Body Diode Reverse Recovery Charge	Q _{rr}			10	20	nC
Reverse Recovery Fall Time	t _a	$I_F = 6.7 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, \text{ T}_J = 25 ^\circ\text{C}$	<u> </u>	10		- ns
Reverse Recovery Rise Time	t _b			10		

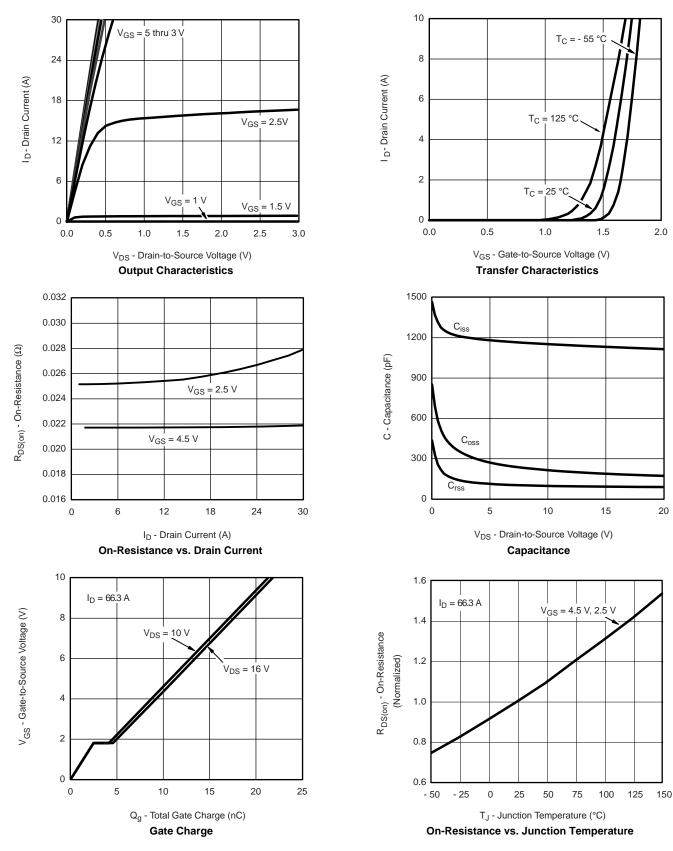
a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%$

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

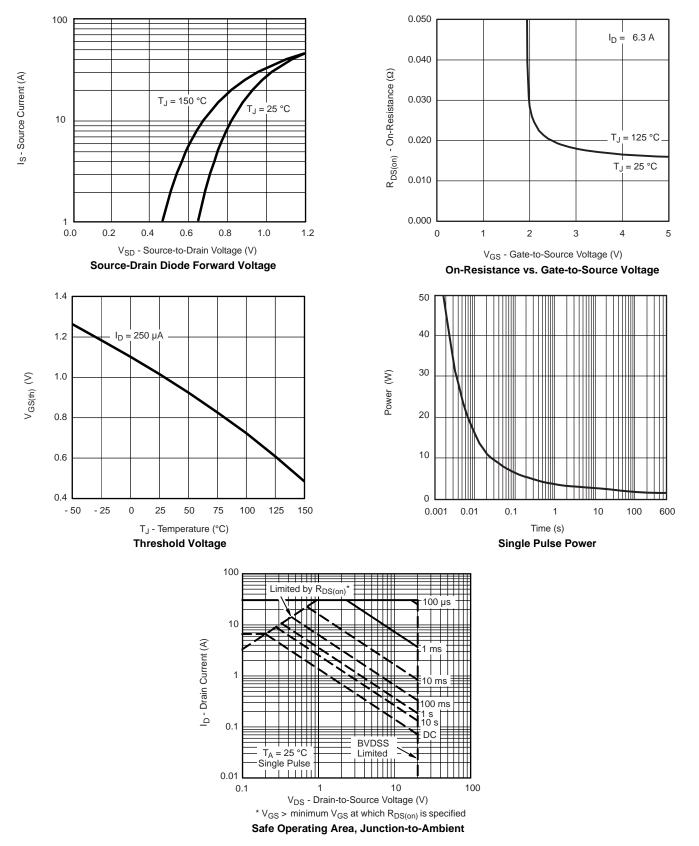
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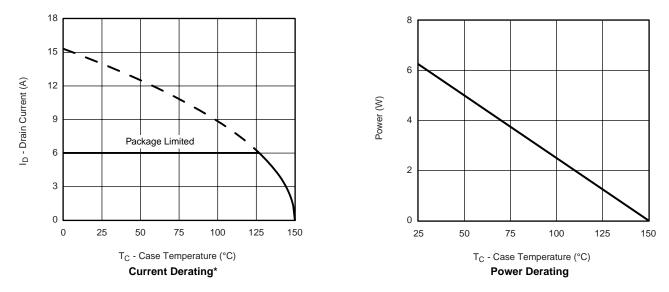


服务热线:400-655-8788



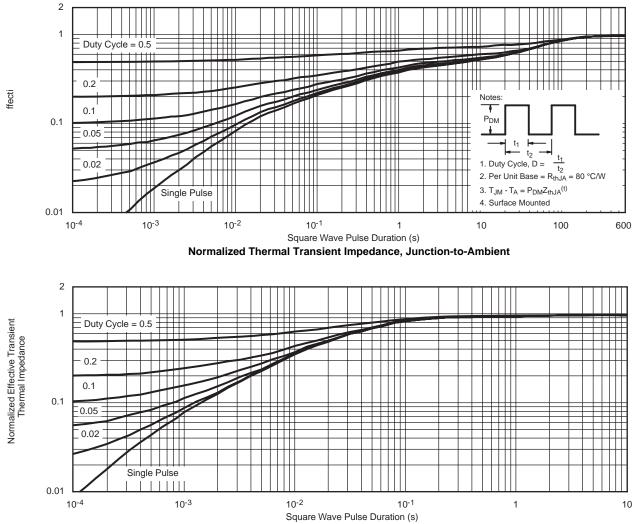






* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



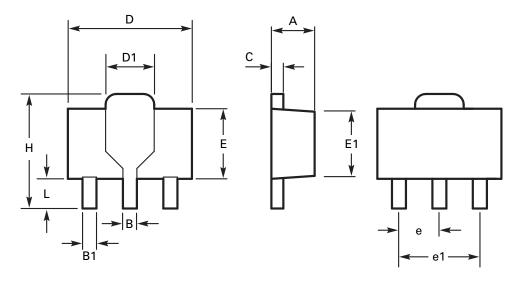


Normalized Thermal Transient Impedance, Junction-to-Foot

XP161A11A1PR-VB



Package outline - SOT89



DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min	Max	Min	Max		Min	Max	Min	Max
А	1.40	1.60	0.550	0.630	E	2.29	2.60	0.090	0.102
В	0.44	0.56	0.017	0.022	E1	2.13	2.29	0.084	0.090
B1	0.36	0.48	0.014	0.019	е	1.50 BSC		0.059 BSC	
С	0.35	0.44	0.014	0.017	e1	3.00 BSC		0.118 BSC	
D	4.40	4.60	0.173	0.181	Н	3.94	4.25	0.155	0.167
D1	1.62	1.83	0.064	0.072	L	0.89	1.20	0.035	0.047

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches



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